P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω) MAX.	I _D (A) ^d	Q _g (TYP.)			
-60	0.105 at V _{GS} = -10 V	-4.3	10.5 nC			
-60	0.136 at V _{GS} = -4.5 V	-3	10.5 110			

FEATURES

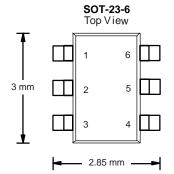
- DT-Trench Power MOSFET
- \bullet 100 % R_g and UIS tested

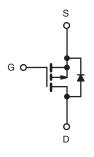
Pb-free

RoHS

APPLICATIONS

- · Load switches
- DC/DC converter





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	-60	V		
Gate-Source Voltage		V _{GS}	± 20	v		
	T _C = 25 °C		-4.3			
Continuous Duoin Comment (T. 150 °C)	T _C = 70 °C		-3.1			
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	-1.5 ^{a,b}			
	T _A = 70 °C		-1.2 ^{a,b}			
Pulsed Drain Current (t = 100 μs)		I _{DM}	-17.2	Α		
Cantinuous Sauras Drain Diada Current	T _C = 25 °C		-4.3			
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	-1.7 ^{a,b}			
Avalanche Current	. 0.1!!	I _{AS}	-15			
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	11.55	mJ		
	T _C = 25 °C		4.3			
Maximum Power Dissipation	T _C = 70 °C		2.6	W		
	T _A = 25 °C	P _D	2.3 ^{a,b}	vv		
	T _A = 70 °C		1.4 ^{a,b}			
Operating Junction and Storage Temperature Rang	je	T _J , T _{stg}	-55 to 150	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient a,c	t ≤ 10 s	R _{thJA}	40	65.5	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	25	30	C/ VV	

Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on T_C = 25 °C.

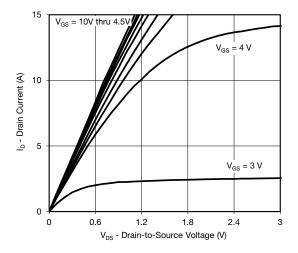
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = -250 μA	-60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-6.7	-		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	l _D = -250 μA	-	4.3	-	mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zaus Cata Valtaga Dusia Courset		$V_{DS} = -48 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μА	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -48 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-4.3	-	-	Α	
Durin Co Co. Olala Berinlana 3	Б	V _{GS} = -10 V, I _D = -3.5 A	-	0.136	0.169	Ω	
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = -4.5 V, I _D = -2.5 A	-	0.105	0.130		
Forward Transconductance a	9 _{fs}	$V_{DS} = -30 \text{ V}, I_{D} = -3.5 \text{ A}$	-	11	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	850	-	pF	
Output Capacitance	C _{oss}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	86	-		
Reverse Transfer Capacitance	C _{rss}		-	62	-		
	Q_g	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	- 20	30			
Total Gate Charge			-	10.5	15.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -2.5 \text{ A}$	-	3.2	-	nC	
Gate-Drain Charge	Q _{gd}		-	3.7	-		
Gate Resistance	R_g	f = 1 MHz	1.6	8	21	Ω	
Turn-On Delay Time	t _{d(on)}		-	8	-		
Rise Time	t _r	$V_{DD} = -30 \text{ V}, R_1 = 10.7 \Omega$	-	6	-	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -2.8 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	32	-		
Fall Time	t _f		-	17	-		
Turn-On Delay Time	t _{d(on)}		-	41	-	ns	
Rise Time	t _r	$V_{DD} = -30 \text{ V}, R_{L} = 10.7 \Omega$	-	26	-	1	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -2.8 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		30	-	1	
Fall Time	t _f		-	15	-		
Drain-Source Body Diode Characterist	ics		<u> </u>		<u> </u>	l	
Continous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	-4.3		
Pulse Diode Forward Current (t = 100 μs)	I _{SM}		-	-	-20	Α	
Body Diode Voltage	V _{SD}	I _S = -2.8 A, V _{GS} = 0 V	-	-0.75	-1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	30	49	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			41	67	nC	
Reverse Recovery Fall Time	t _a	T _J = 25 °C	-	25	-		
Reverse Recovery Rise Time	t _b	-		8	-	ns	

Notes

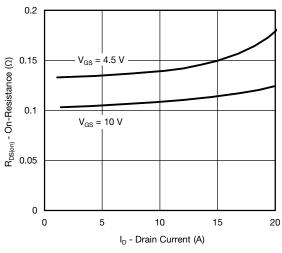
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

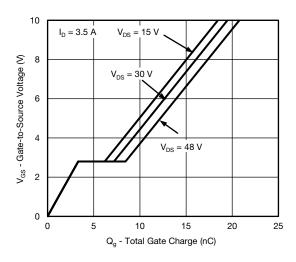




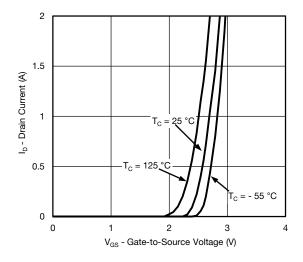
Output Characteristics



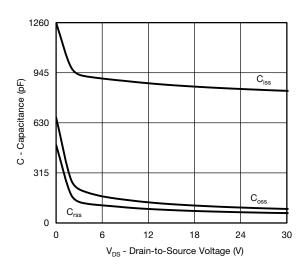
On-Resistance vs. Drain Current



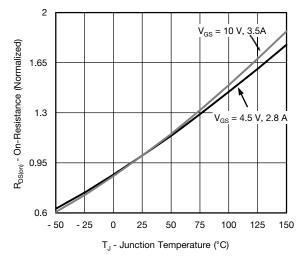
Gate Charge



Transfer Characteristics

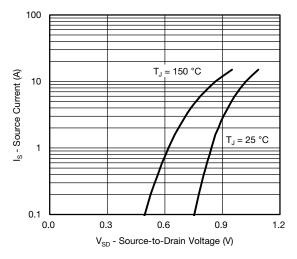


Capacitance

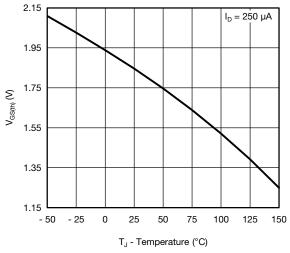


On-Resistance vs. Junction Temperature

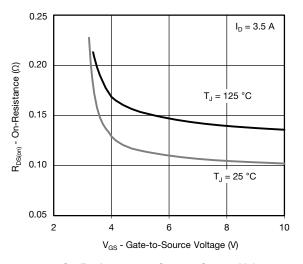




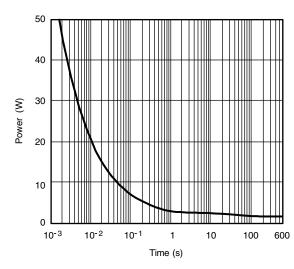
Source-Drain Diode Forward Voltage



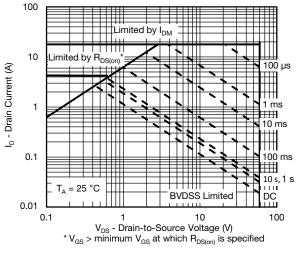
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

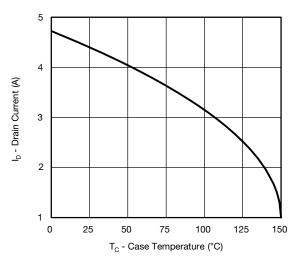


Single Pulse Power, Junction-to-Ambient

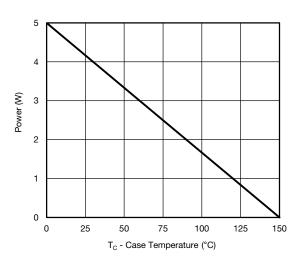


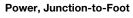
Safe Operating Area

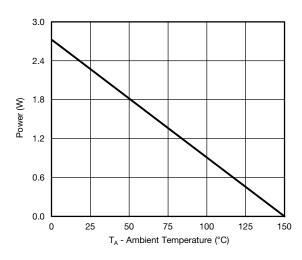




Current Derating*



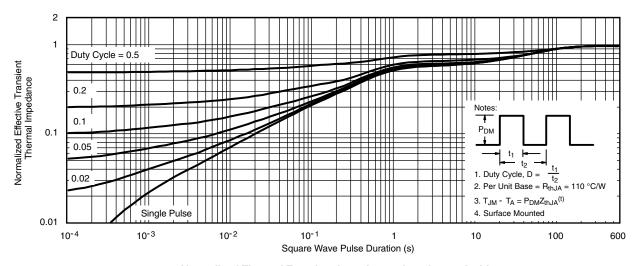




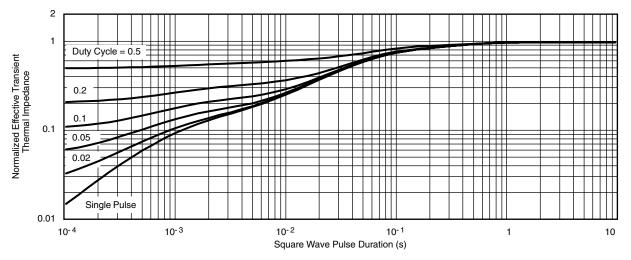
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J (max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



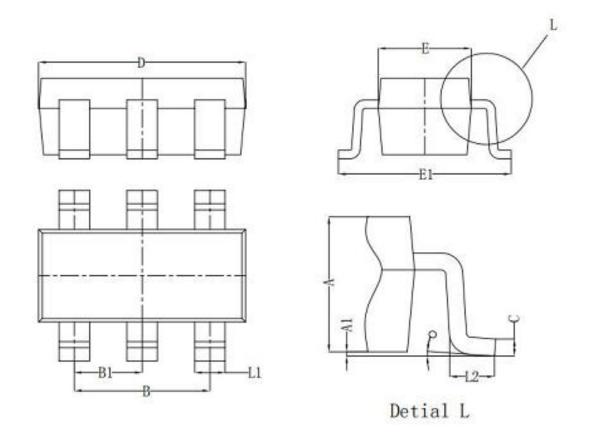


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

SOT-23-6L PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	
Α	0.95	1.10	1.35	
A1	0.00	0.05	0.12	
L1	0.25	0.40	0.55	
С	0.08	0.15	0.22	
D	2.77	2.92	3.12	
Е	1.45	1.60	1.75	
E1	2.50	2.80	3.10	
В	1.75	1.90	2.10	
B1	0.95TYP			
L2	0.28	0.45	0.63	
0	0°	4°	8°	





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